

# **Enhancement Mode P-Channel Power MOSFET**

SOT23/PMOS/-30V/ $\pm$ 12V/-0.9V/-4.2A/49m $\Omega$ 

Rev1.6





## -30V, $49m\Omega$ , -4.2A, P-Channel MOSFET

#### 1.Features

- Advanced Trench Technology
- ◆ Surface mount package

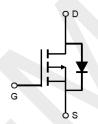
#### 2.Applications

- ◆ Power Management
- Load Switching

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SOT23 Pin Description

V <sub>DS</sub>	R <sub>DS(on)</sub> Typ.	I <sub>D</sub> .
	49mΩ @ -10V	
-30V	55mΩ @ -4.5V	-4.2A
	70mΩ @ -2.5V	



Schematic Diagram

#### 3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP3401SS	A19T	SOT23	3,000	180,000

#### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V <sub>DSS</sub>	-30	V
Gate to Source Voltage	V <sub>GSS</sub>	±12	V
Drain Current (DC)	ID	-4.2	А
Drain Current (Pulse), PW≤300μs	I <sub>DP</sub>	-16	А
Total Dissipation	P <sub>D</sub>	1.2	W
Junction Temperature	Tj	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### 5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	Reja	108	°C/W

Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.

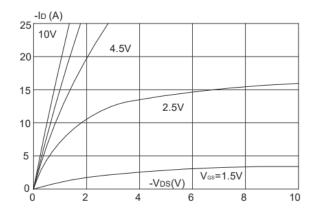
#### 6.Electrical Characteristics at Ta=25°C (Note 3)

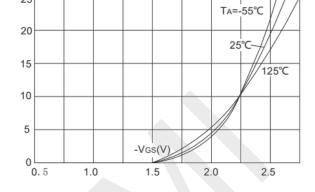
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$I_D = -250 \mu A$ , $V_{GS} = 0 V$	-30			V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -27V, V <sub>GS</sub> = 0V			-1	uA
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 12V, V_{DS} = 0V$	,		±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =-250μA	-0.6	-0.9	-1.3	V
		I <sub>D</sub> =-4A, V <sub>GS</sub> =-10V		49	54	mΩ
Static Drain to Source On-State Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> =-3A, V <sub>GS</sub> =-4.5V		55	65	mΩ
redistance		I <sub>D</sub> =-1A, V <sub>GS</sub> = -2.5V		70	85	mΩ
Input Capacitance	Ciss	V <sub>GS</sub> =0V,		553		pF
Output Capacitance	Coss	V <sub>DS</sub> =-15V, Frequency=1.0MHz		57		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			35		pF
Turn-ON Delay Time	t <sub>d(on)</sub>			10		ns
Rise Time	tr	V <sub>DD</sub> =-15V, I <sub>D</sub> =-3A,		86		ns
Turn-OFF Delay Time	t <sub>d(off)</sub>	$R_G = 2.5\Omega$ , $V_{GS} = -4.5V$		150		ns
Fall Time	t <sub>f</sub>			357		ns
	Qg	$V_{DS} = -15V,$ $V_{GS} = -4.5V,$ $I_{D} = -3A$		6.5		nC
Total Gate Charge	Qgs			1.4		nC
	$Q_{gd}$			1.7		nC
Diode Forward Voltage	$V_{FSD}$	I <sub>S</sub> = -4A, V <sub>GS</sub> = 0	-0.4	-0.9	-1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



#### 7. Typical Electrical and Thermal Characteristics

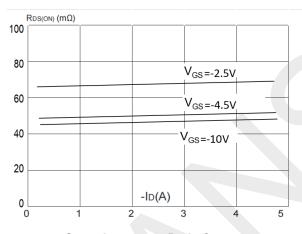


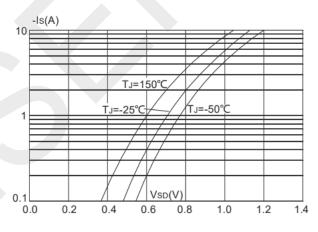


-ID (A)

**Output Characteristics** 

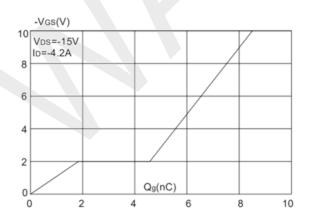
**Typical Transfer Characteristics** 

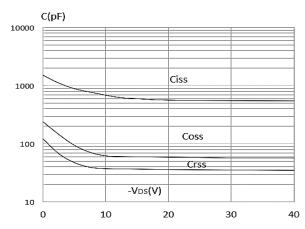




On-resistance vs. Drain Current

**Body Diode Characteristics** 

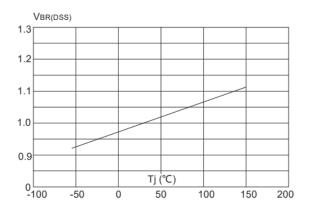




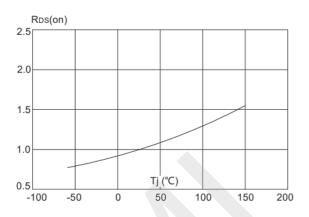
**Gate Charge Characteristics** 

**Capacitance Characteristics** 

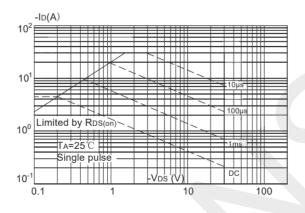




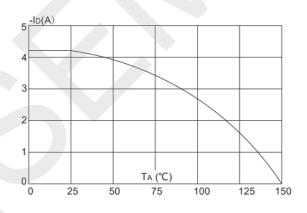
Normalized Breakdown Voltage vs. Junction Temperature



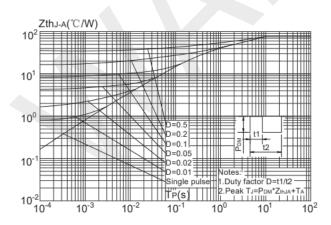
Normalized on Resistance vs.Junction Temperature



**Maximum Safe Operating Area** 



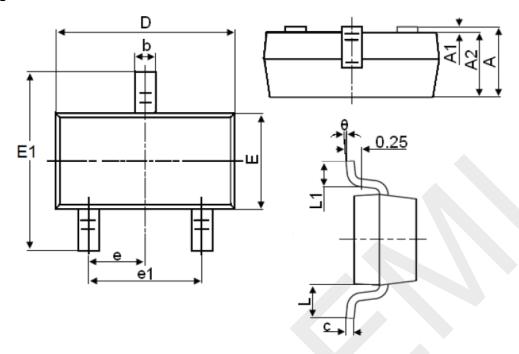
Maximum Continuous Drain Current vs.
Ambient Temperature



Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



### 8.Package Dimensions



	Dir	Dimensions in Millimeters			
Symbol	MIN.	TYP.	MAX.		
А	0.900		1.150		
A1 .	0.000		0.100		
A2	0.900		1.050		
b	0.300		0.500		
С	0.080		0.150		
D	2.800		3.000		
E	1.200		1.400		
E1	2.250		2.550		
е		0.950			
e1	1.800		2.000		
L		0.550			
L1	0.300		0.500		
θ	0°		8°		



#### 9.Important Notice

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